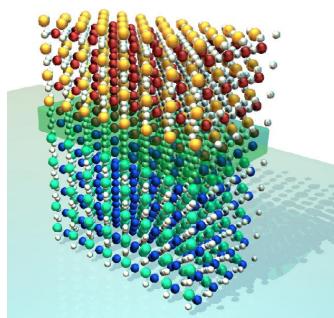


Valence Band Analysis of LaAlO₃/SrTiO₃ Heterostructures using Hard X-Ray Photoelectron Spectroscopy

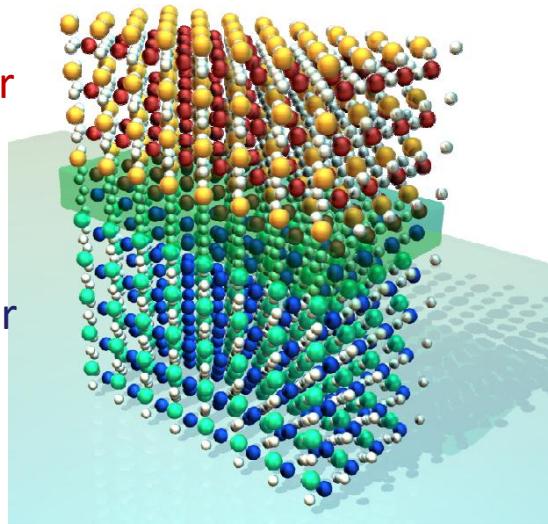
G. Berner, F. Pfaff, A. Müller,
S. Paetel, C. Richter, J. Mannhart,
A. Hloskovskyy, W. Drube, M. Sing and R. Claessen



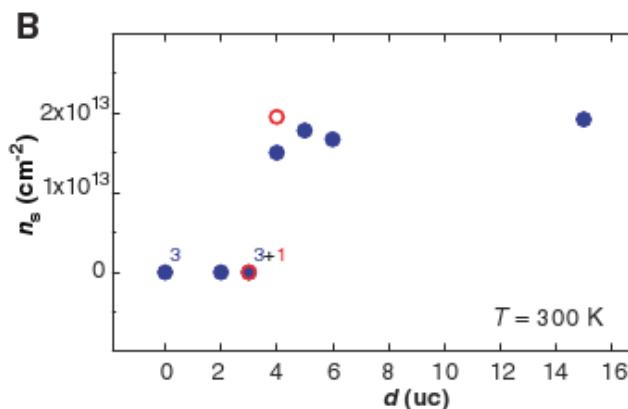
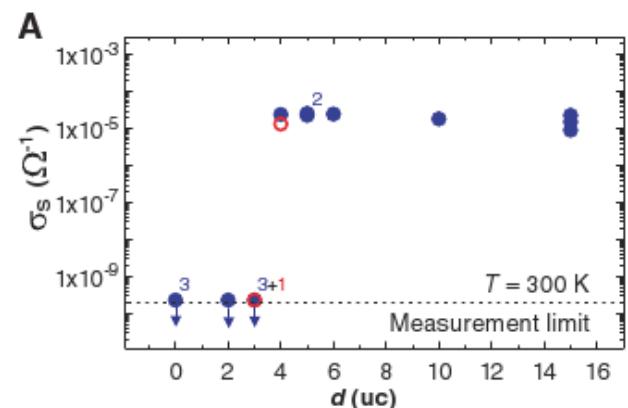
- epitaxial growth by pulsed laser deposition
- more than 3uc LAO:
formation of **2DEG** at the interface
- electrostatic tuning of the interface properties (field effect)

LaAlO₃:
Band insulator
 $\Delta=5.6\text{eV}$

SrTiO₃:
Band insulator
 $\Delta=3.2\text{eV}$



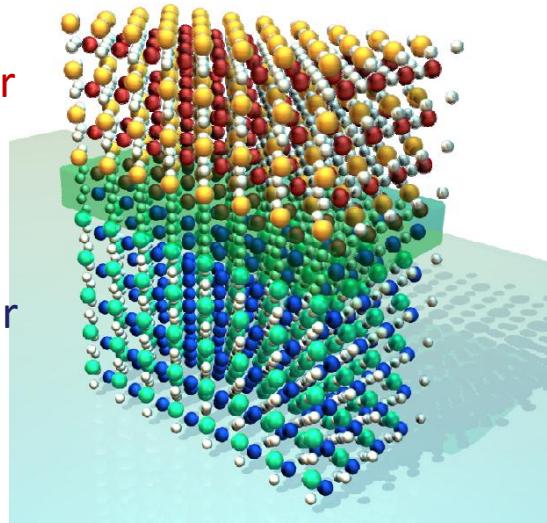
Critical thickness: $\geq 4\text{uc}$



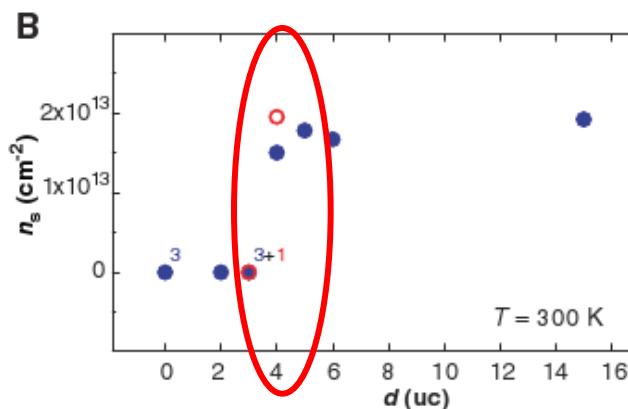
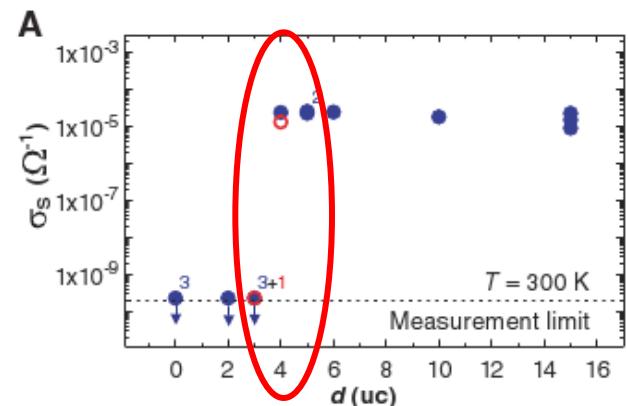
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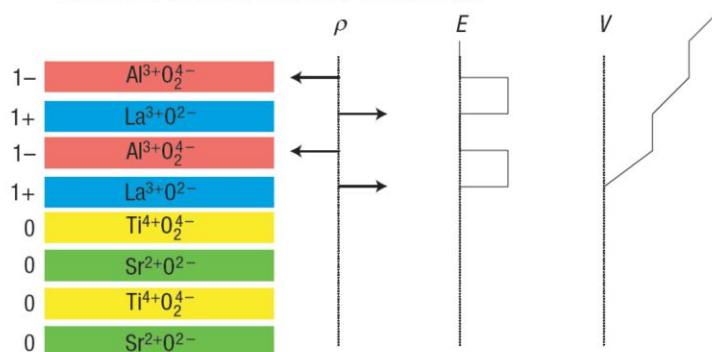


Critical thickness: $\geq 4\text{uc}$



intrinsic

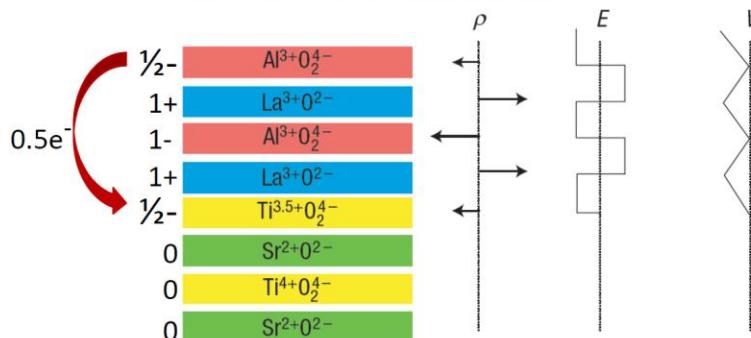
electronic reconstruction

before reconstruction:

extrinsic

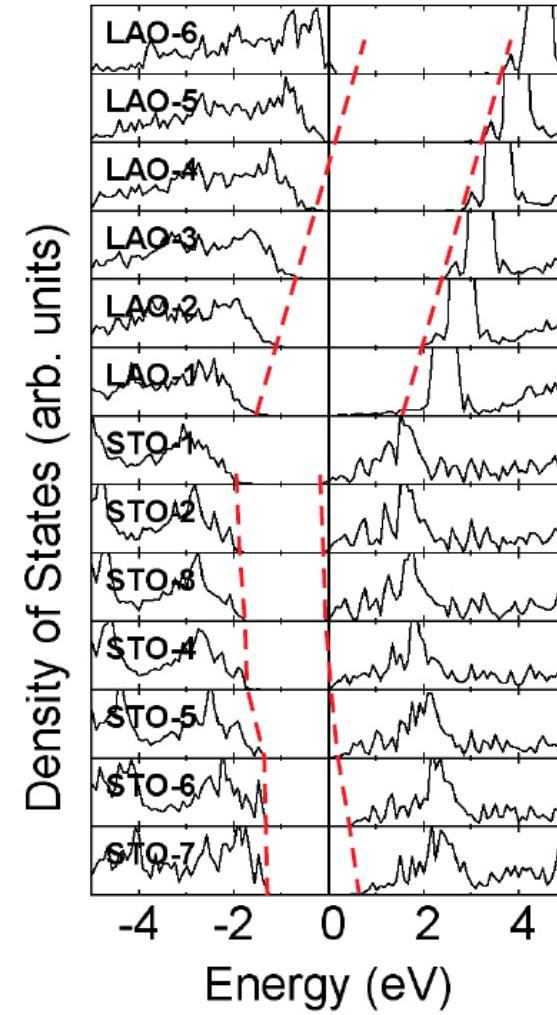
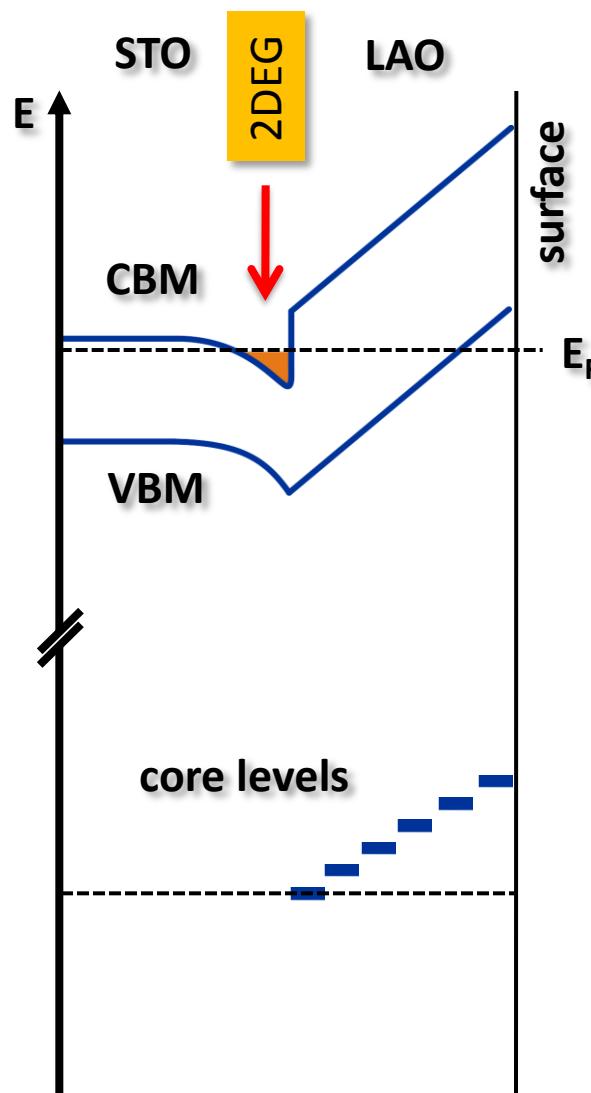
oxygen vacancies /
preparation properties

La/Sr intermixing

after reconstruction:**in experiments:**

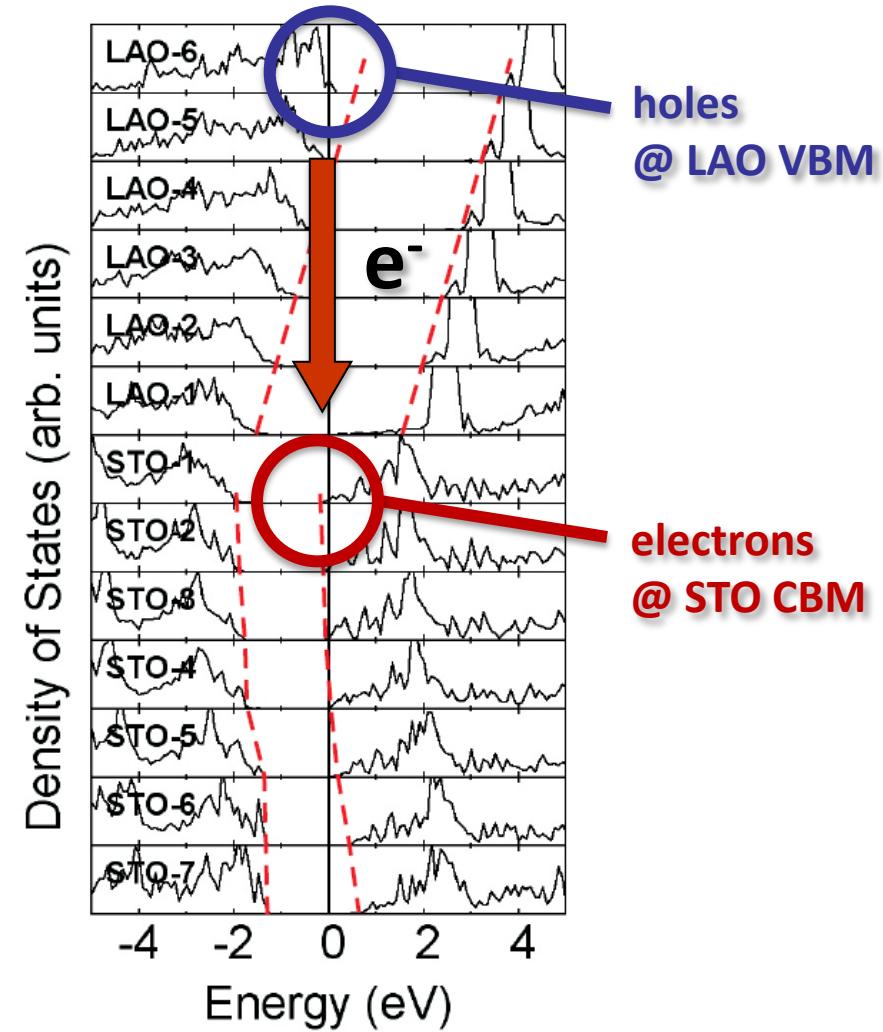
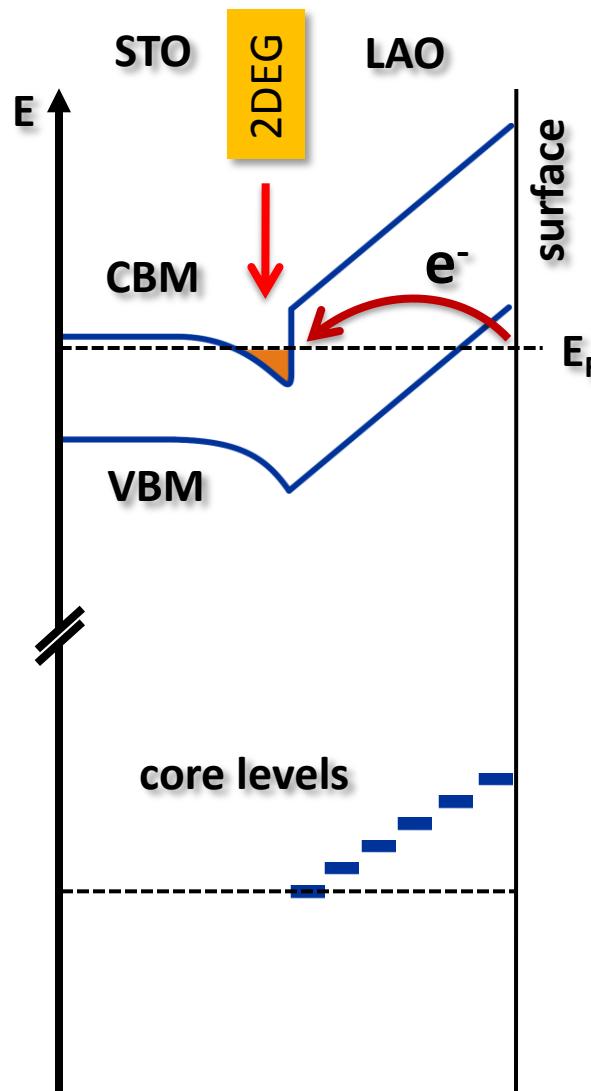
- carrier density much **smaller** ($n_{2D} \approx 5 \cdot 10^{13} \text{ cm}^{-2}$)
- 2DEG confined to only **a few unit cells (uc)** in STO

$$0.5e^- \rightarrow n_{2D} \approx 3.4 \cdot 10^{14} \text{ cm}^{-2}$$



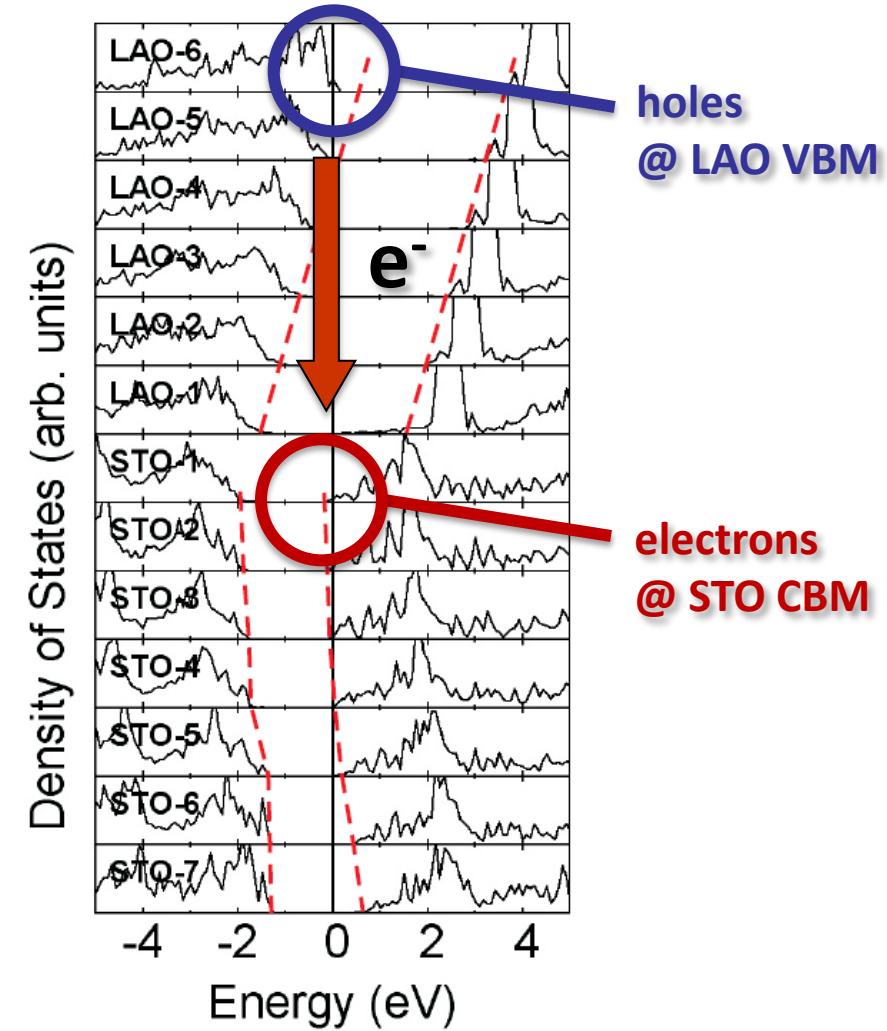
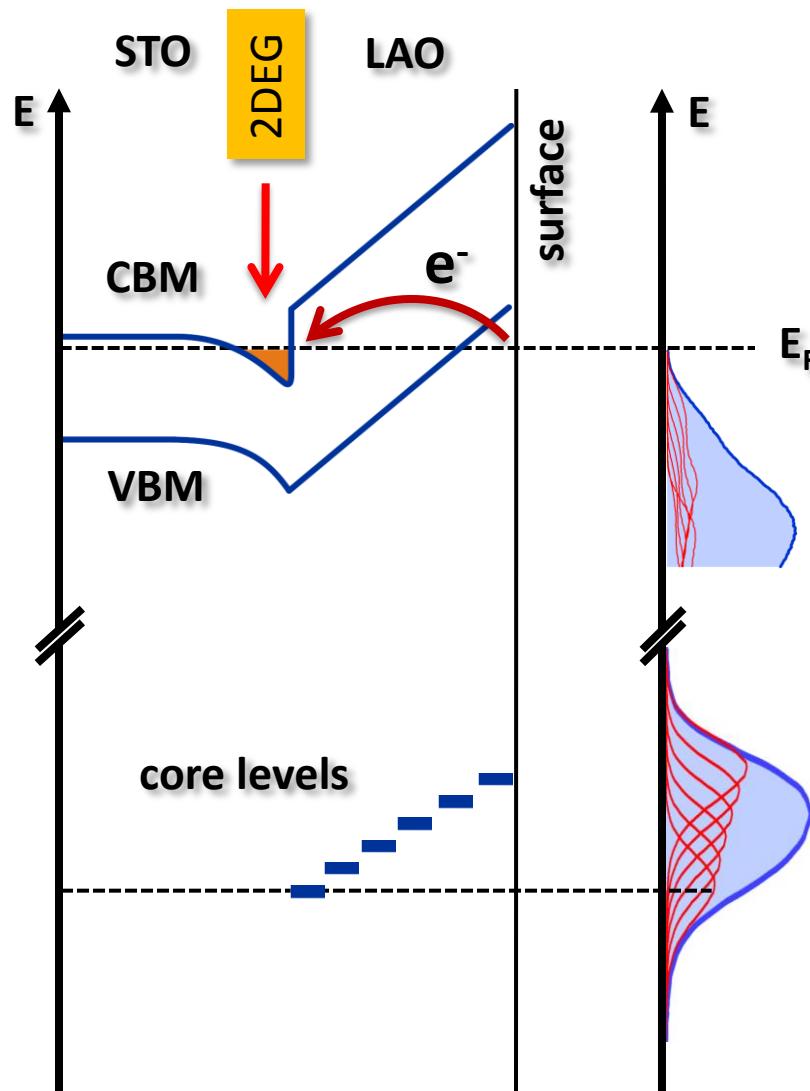
Yu Lin et al., arXiv 0904.1636 (2009)

Pentcheva and Pickett, PRL 102, 107602 (2009)



Yu Lin et al., arXiv 0904.1636 (2009)

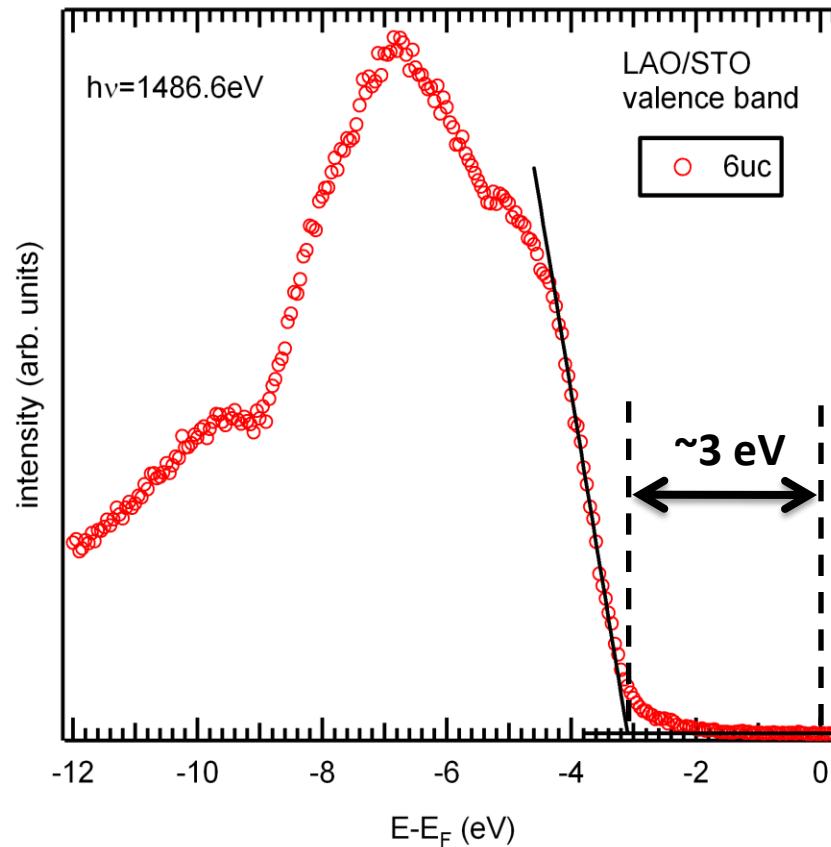
Pentcheva and Pickett, PRL 102, 107602 (2009)



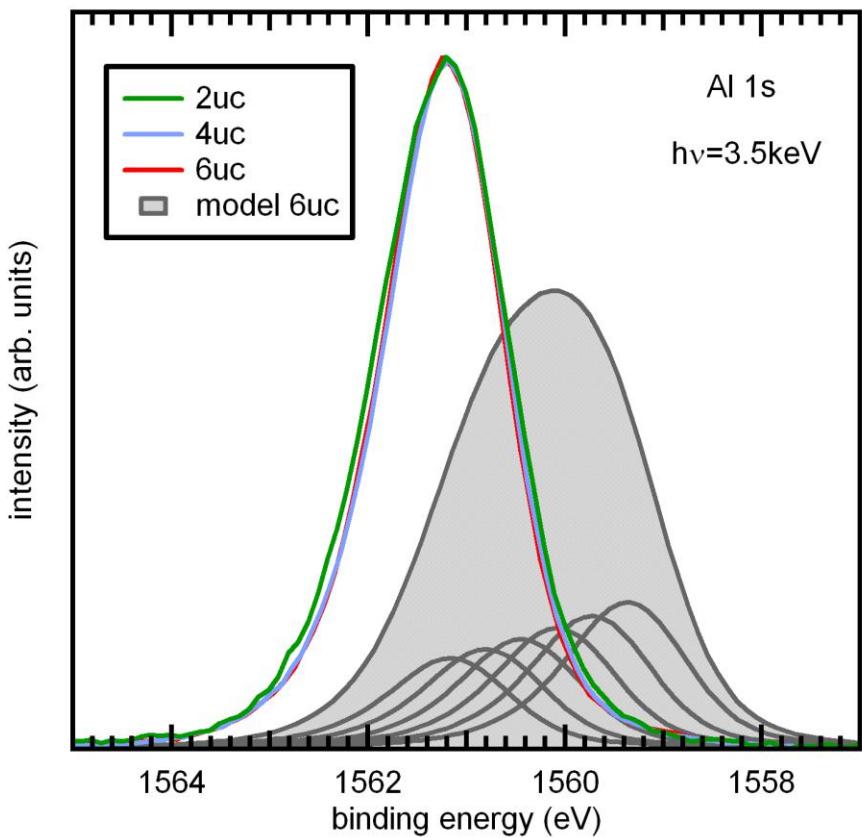
Yu Lin et al., arXiv 0904.1636 (2009)

Pentcheva and Pickett, PRL 102, 107602 (2009)

valence band



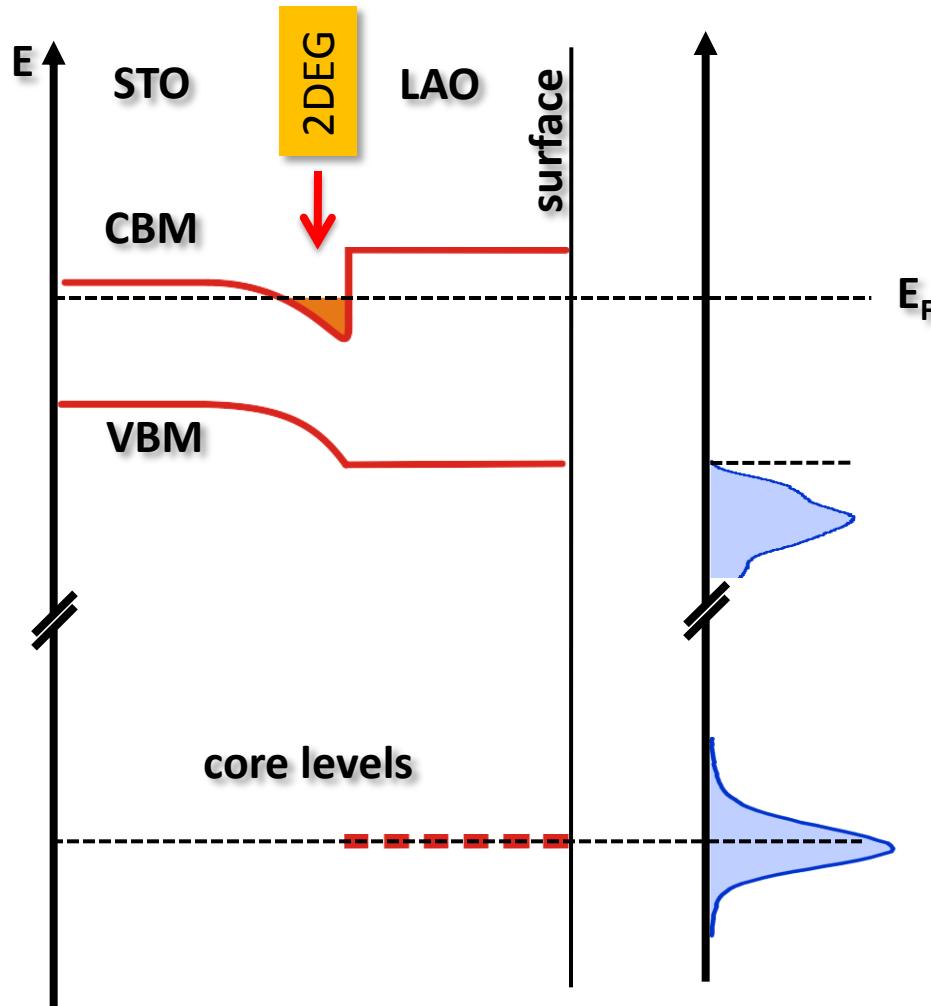
Al 1s core level



VBM: ~ 3 eV below E_F

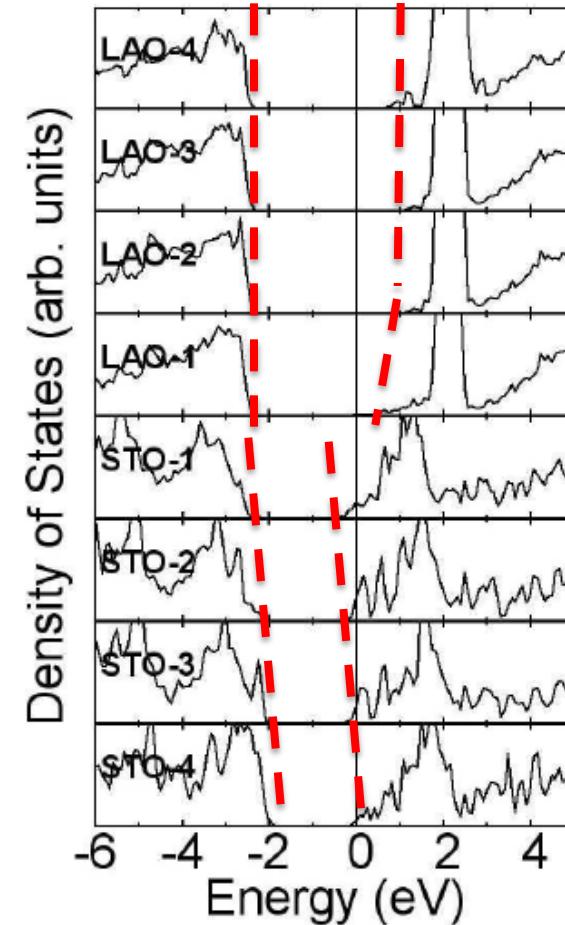
same width for all samples!

picture from XPS



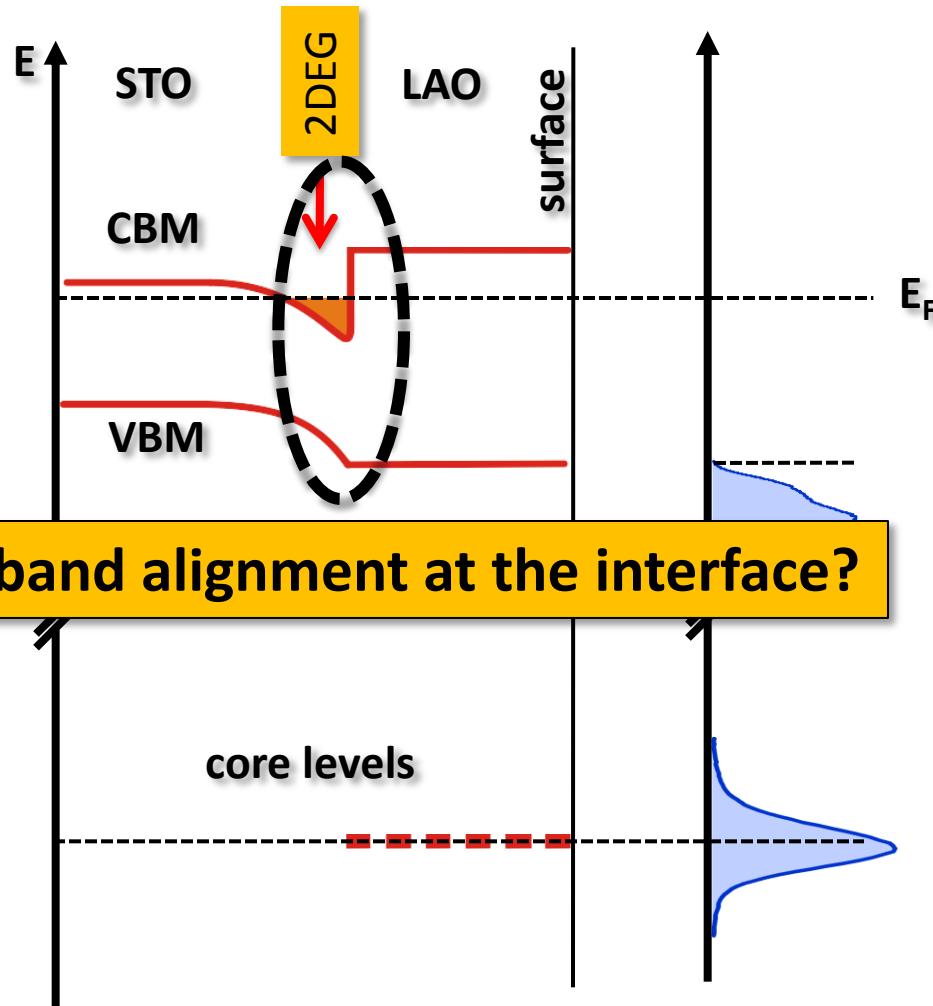
also observed by Segal et al., PRB 80, 241107(R) (2009)

band theory
oxygen vacancies at LAO surface



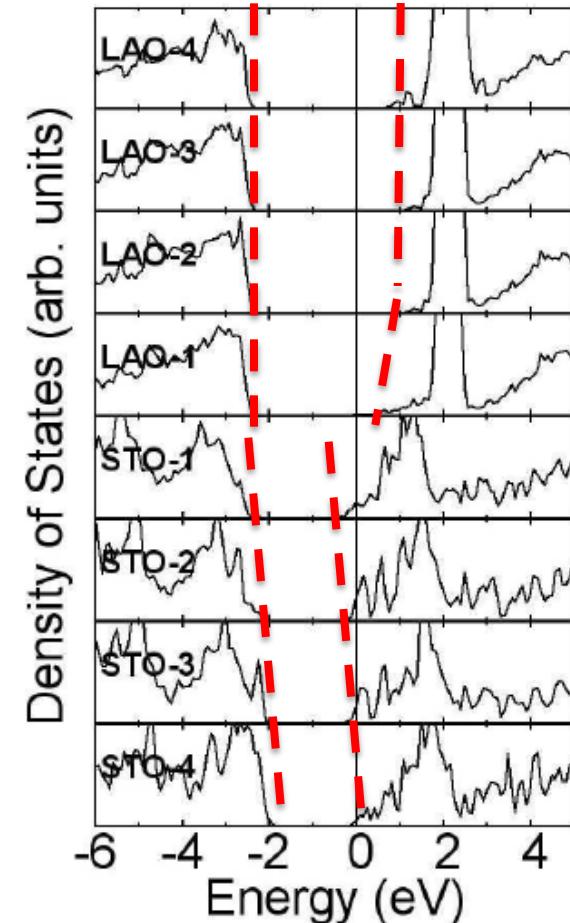
Yu Lin et al., arXiv 0912.4805 (2009)
Cen et al., Nat. Mat. 2136 (2008)

picture from XPS



also observed by Segal et al., PRB 80, 241107(R) (2009)

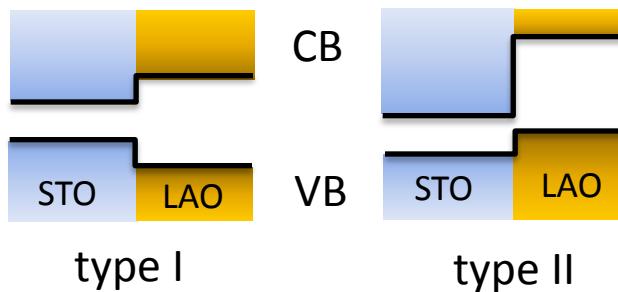
band theory
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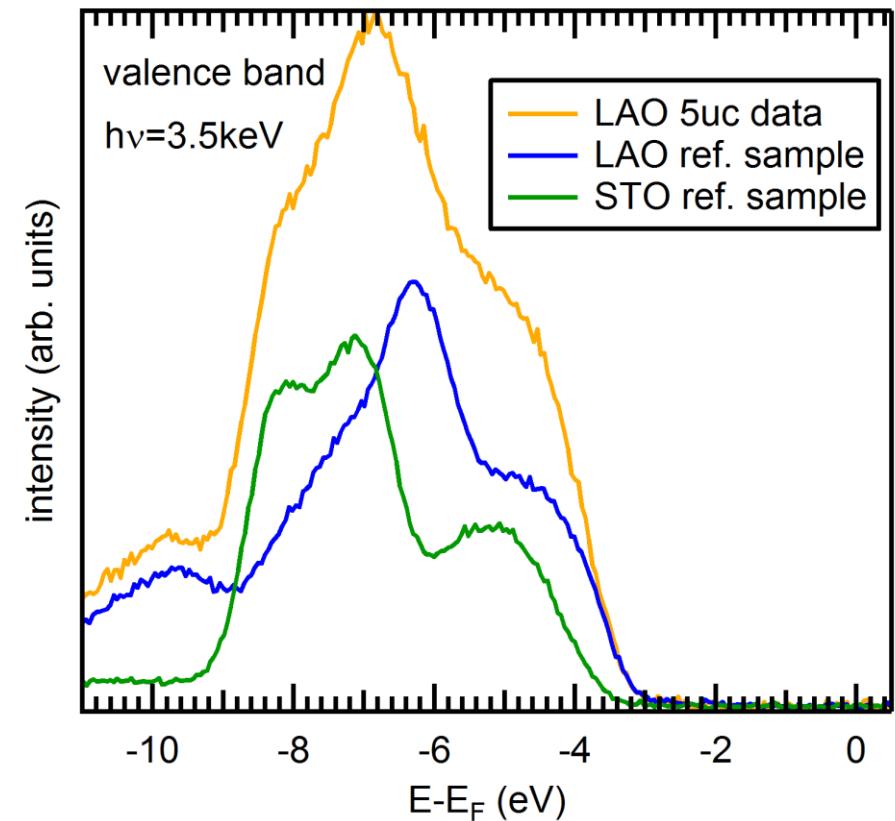
Yu Lin et al., arXiv 0912.4805 (2009)
Cen et al., Nat. Mat. 2136 (2008)

Valence band offsets

band alignment

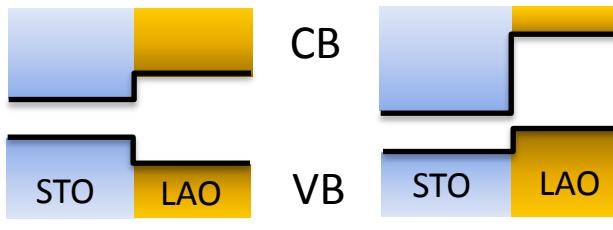


valence band analysis



Valence band offsets

band alignment



type I

CB

STO

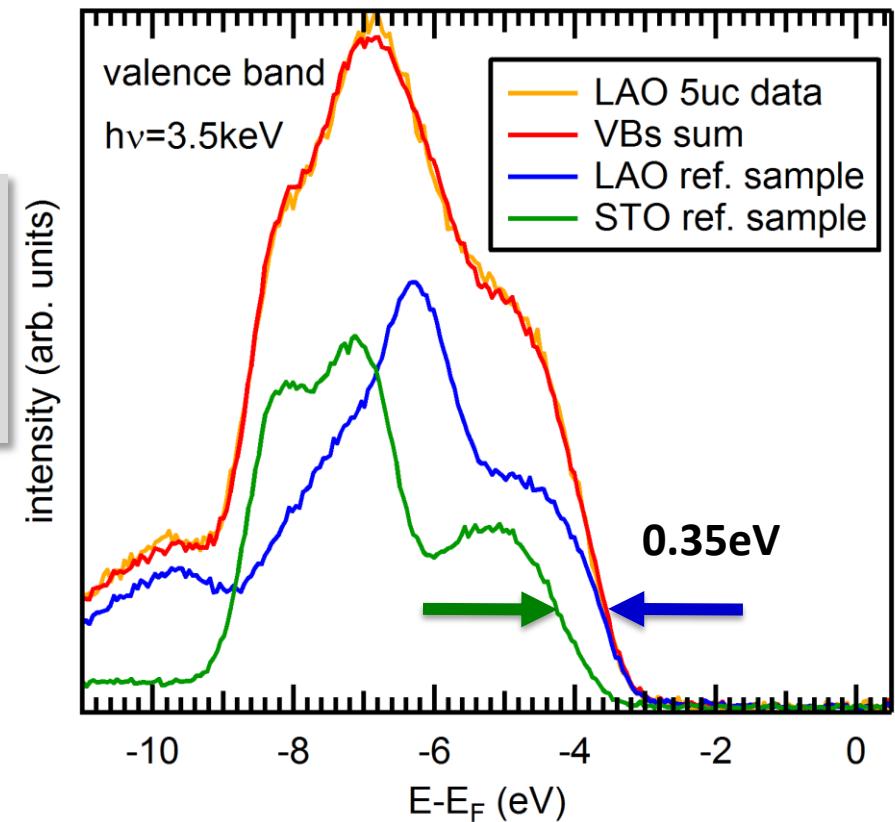
LAO

VB

STO LAO

type II

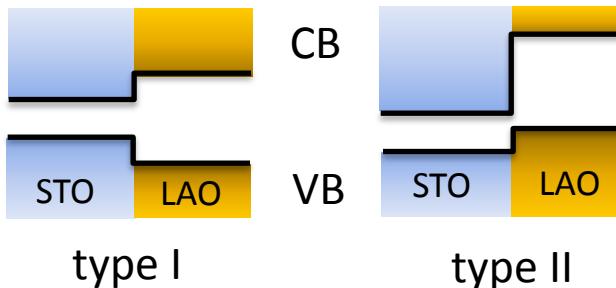
valence band analysis



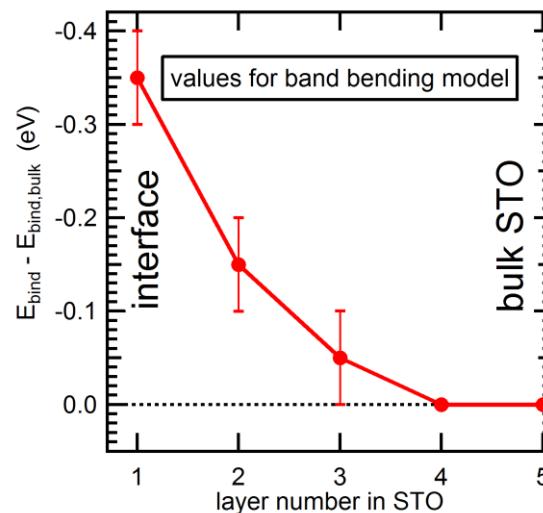
confirmed by core level analysis!

- VBM_{LAO} **above** VBM_{STO}
- **type II** interface
(valence band offset: **0.35 ± 0.1 eV**)
- **independent** of LAO thickness

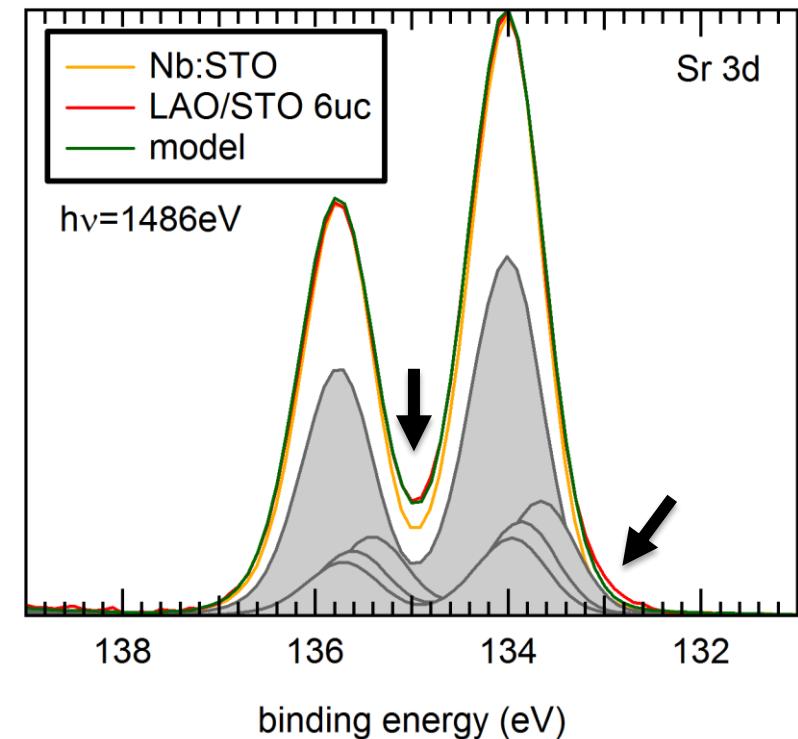
band alignment



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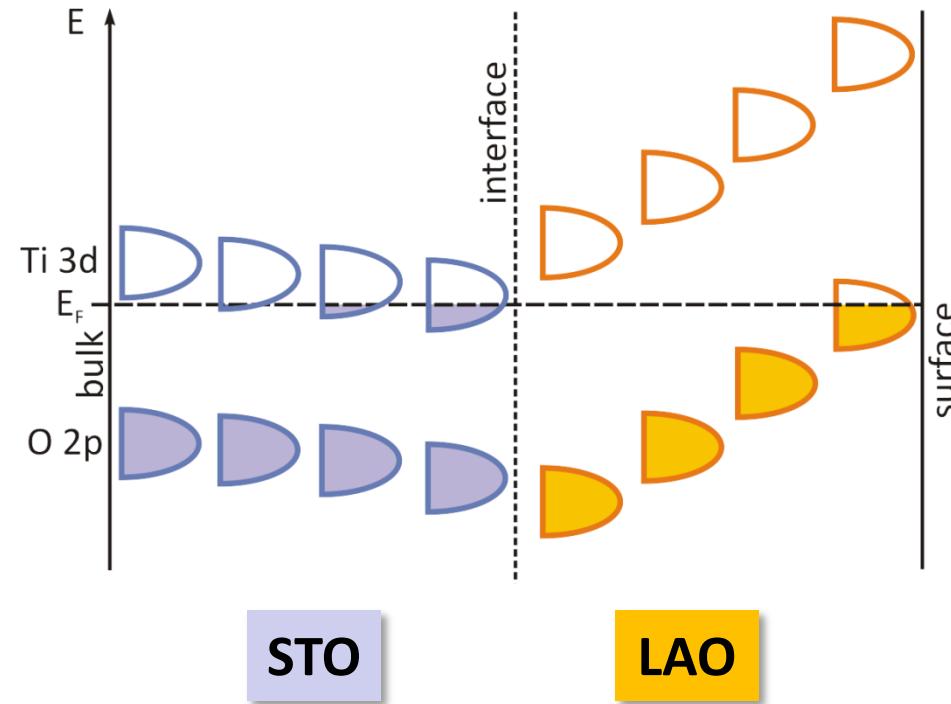
Sr 3d core level



upward band bending in first layers of STO!

Band alignment: A possible scenario

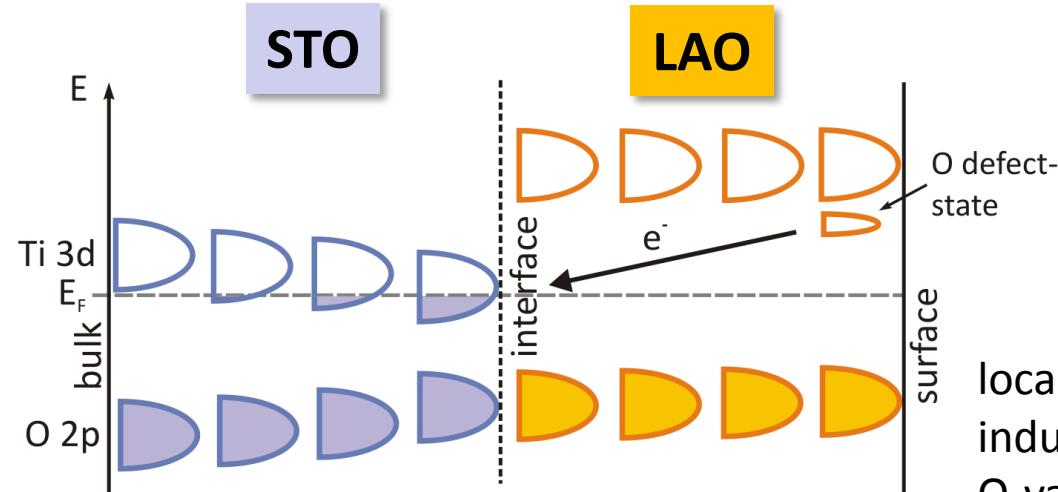
DFT band theory:



Band alignment: A possible scenario

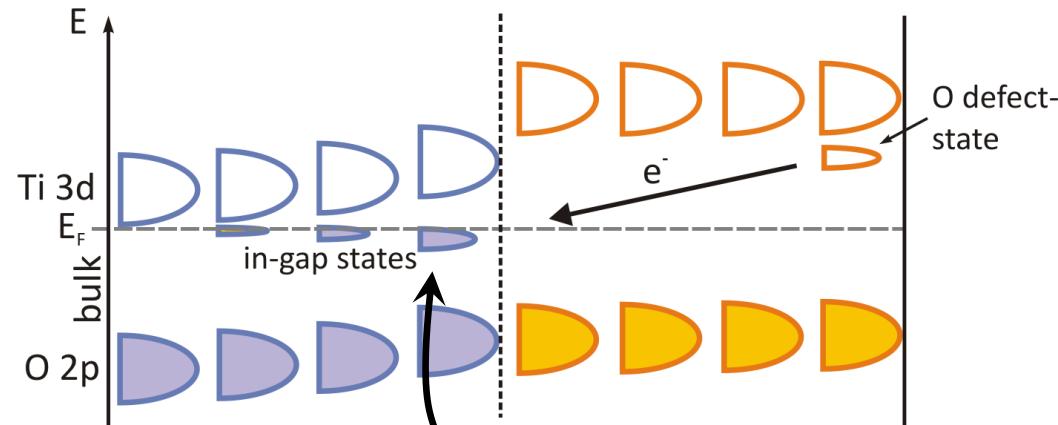
Photoemission:

(a)



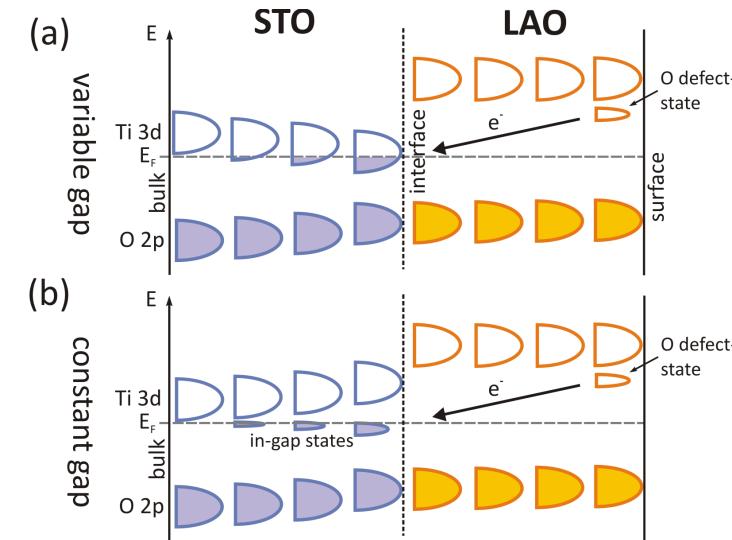
localized hole states
induced by surface
O-vacancies

(b)



interface states (itinerant and localized)

- „flat band“ behavior in LAO overlayer
- **HAXPES vs. DFT:**
qualitative agreement if oxygen defects are included in calculations
- band alignment: **type II** interface
- two possible scenarios from HAXPES



open issues:

- confirmation of interface states / band gap narrowing by theory?
- influence of photo-generated carriers?
- ...